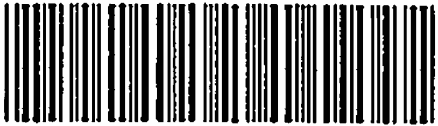
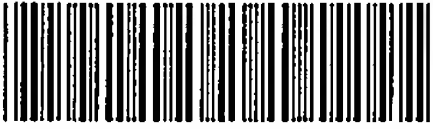


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10633642	FURUKAWA ET AL.
	Examiner Chang, Rick K	Art Unit 3729

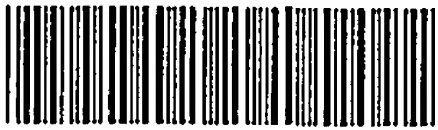
Notes	Date	Examiner
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east search	7/27/06	rc
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<i>Interference Searched</i> 	Application/Control No. 10633642	Applicant(s)/Patent Under Reexamination FURUKAWA ET AL.
	Examiner Chang, Rick K	Art Unit 3729

Class	SubClass	Date	Examiner
29,338	subs. under searched	7/27/06	RC

U.S. Patent and Trademark Office	Part of Paper No.: 20060727
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<div>Searched</div> <div></div>	Application/Control No. 10633642	Applicant(s)/Patent Under Reexamination FURUKAWA ET AL.
	Examiner Chang, Rick K	Art Unit 3729

Class	SubClass	Date	Examiner
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search updated		7/27/06	rc
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